

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination 10/049236	
	Examiner WEIER	Art Unit 1761	Page of

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4143172	3-1979	Mitchell et al	—
	B	US-4562081	12-1985	Buttermann III	—
	C	US-4084010	4-1978	Takemoto et al	—
	D	US-4906482	3-1990	Zemel et al	—
	E	US-4675200	6-1987	Serpelloni et al	—
	F	US-4064277	12-1977	Yokotsuka et al	—
	G	US-6316043	11-2001	Tsumura et al	—
	H	US-5945151	8-1999	Sato et al	—
	I	US-6022568	2-2000	Lesens et al	—
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 58-212749	12-1983	Japan	—	—
	O	JP 61-96953	5-1986	Japan	—	—
	P	JP 8-182468	7-1996	Japan	—	—
	Q	JP 4-152848	5-1992	Japan	—	—
	R	JP 2001-252022	9-2001	Japan	—	—
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.